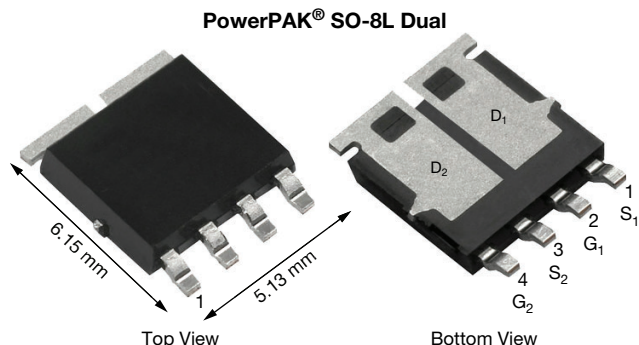
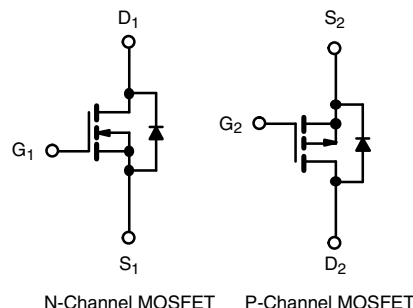


Automotive N- and P-Channel 40 V (D-S) 175 °C MOSFET



FEATURES

- TrenchFET® power MOSFET
- AEC-Q101 qualified
- 100 % R_g and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



PRODUCT SUMMARY		
	N-CHANNEL	P-CHANNEL
V _{DS} (V)	40	-40
R _{DS(on)} (Ω) at V _{GS} = ± 10 V	0.0075	0.0170
R _{DS(on)} (Ω) at V _{GS} = ± 4.5 V	0.0110	0.0230
I _D (A)	30	-30
Configuration	N- and p-pair	
Package	PowerPAK SO-8L Dual	

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Drain-source voltage			V _{DS}	40	-40	V
Gate-source voltage			V _{GS}	± 20		
Continuous drain current	T _C = 25 °C		I _D	30 ^a	-30 ^a	A
	T _C = 125 °C			29.3	-19.5	
Continuous source current (diode conduction) ^a			I _S	30	-30	
Pulsed drain current ^b			I _{DM}	90	-84	
Single pulse avalanche current	L = 0.1 mH		I _{AS}	25	-24	
Single pulse avalanche Energy			E _{AS}	31.2	28.8	mJ
Maximum power dissipation ^b	T _C = 25 °C		P _D	34	34	W
	T _C = 125 °C			11	11	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +175		°C
Soldering recommendations (peak temperature) ^{d, e}				260		

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Junction-to-ambient	PCB mount ^c	R _{thJA}	85	85	°C/W
Junction-to-case (drain)		R _{thJC}	4.3	4.3	

Notes

- Package limited
- Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %
- When mounted on 1" square PCB (FR4 material)
- See solder profile (www.vishay.com/doc?73257). The PowerPAK SO-8L is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components

**SPECIFICATIONS** ($T_C = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP.	MAX.	UNIT	
Static									
Drain-source breakdown voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA		N-Ch	40	-	-	V	
		V _{GS} = 0 V, I _D = -250 μA		P-Ch	-40	-	-		
Gate-source threshold voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA		N-Ch	1.5	2	2.5	V	
		V _{DS} = V _{GS} , I _D = -250 μA		P-Ch	-1.5	-2	-2.5		
Gate-source leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V		N-Ch	-	-	± 100	nA	
				P-Ch	-	-	± 100		
Zero gate voltage drain current	I _{DSS}	V _{GS} = 0 V	V _{DS} = 40 V	N-Ch	-	-	1	μA	
		V _{GS} = 0 V	V _{DS} = -40 V	P-Ch	-	-	-1		
		V _{GS} = 0 V	V _{DS} = 40 V, T _J = 125 °C	N-Ch	-	-	50		
		V _{GS} = 0 V	V _{DS} = -40 V, T _J = 125 °C	P-Ch	-	-	-50		
		V _{GS} = 0 V	V _{DS} = 40 V, T _J = 175 °C	N-Ch	-	-	150		
		V _{GS} = 0 V	V _{DS} = -40 V, T _J = 175 °C	P-Ch	-	-	-150		
On-state drain current ^a	I _{D(on)}	V _{GS} = 10 V	V _{DS} ≥ 5 V	N-Ch	10	-	-	A	
		V _{GS} = -10 V	V _{DS} ≤ 5 V	P-Ch	-10	-	-		
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = 10 V	I _D = 8 A	N-Ch	-	0.0061	0.0075	Ω	
		V _{GS} = -10 V	I _D = -8 A	P-Ch	-	0.0138	0.0170		
		V _{GS} = 10 V	I _D = 8 A, T _J = 125 °C	N-Ch	-	-	0.0110		
		V _{GS} = -10 V	I _D = -8 A, T _J = 125 °C	P-Ch	-	-	0.0254		
		V _{GS} = 10 V	I _D = 8 A, T _J = 175 °C	N-Ch	-	-	0.0130		
		V _{GS} = -10 V	I _D = -8 A, T _J = 175 °C	P-Ch	-	-	0.0304		
		V _{GS} = 4.5 V	I _D = 5 A	N-Ch	-	0.0088	0.0110		
		V _{GS} = -4.5 V	I _D = -5 A	P-Ch	-	0.0186	0.0230		
Forward transconductance ^b	g _{fs}	V _{DS} = 15 V, I _D = 8 A		N-Ch	-	35	-	S	
		V _{DS} = -15 V, I _D = -8 A		P-Ch	-	30	-		
Dynamic ^b									
Input capacitance	C _{iss}	V _{GS} = 0 V	V _{DS} = 25 V, f = 1 MHz	N-Ch	-	1355	1900	pF	
		V _{GS} = 0 V	V _{DS} = -25 V, f = 1 MHz	P-Ch	-	3340	4600		
Output capacitance	C _{oss}	V _{GS} = 0 V	V _{DS} = 25 V, f = 1 MHz	N-Ch	-	875	1400		
		V _{GS} = 0 V	V _{DS} = -25 V, f = 1 MHz	P-Ch	-	230	320		
Reverse transfer capacitance	C _{rss}	V _{GS} = 0 V	V _{DS} = 25 V, f = 1 MHz	N-Ch	-	35	50	pF	
		V _{GS} = 0 V	V _{DS} = -25 V, f = 1 MHz	P-Ch	-	216	300		
Total gate charge ^c	Q _g	V _{GS} = 10 V	V _{DS} = 20 V, I _D = 5 A	N-Ch	-	18	30	nC	
		V _{GS} = -10 V	V _{DS} = -20 V, I _D = -5 A	P-Ch	-	56	85		
Gate-source charge ^c	Q _{gs}	V _{GS} = 10 V	V _{DS} = 20 V, I _D = 5 A	N-Ch	-	3.5	-		
		V _{GS} = -10 V	V _{DS} = -20 V, I _D = -5 A	P-Ch	-	8.5	-		
Gate-drain charge ^c	Q _{gd}	V _{GS} = 10 V	V _{DS} = 20 V, I _D = 5 A	N-Ch	-	2.6	-	nC	
		V _{GS} = -10 V	V _{DS} = -20 V, I _D = -5 A	P-Ch	-	9.9	-		
Gate resistance	R _g	f = 1 MHz			N-Ch	0.3	0.72	1.2	Ω
					P-Ch	1.15	2.37	3.6	

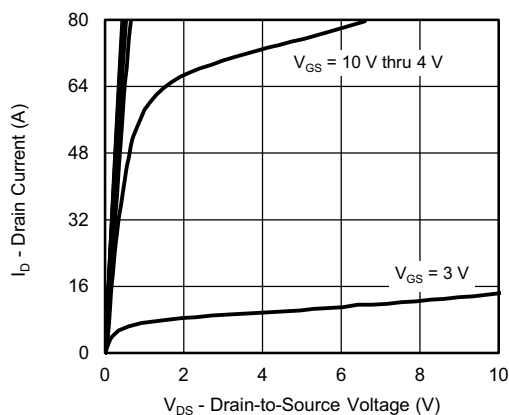
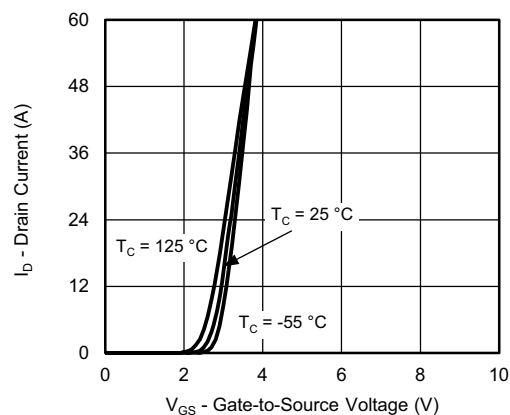
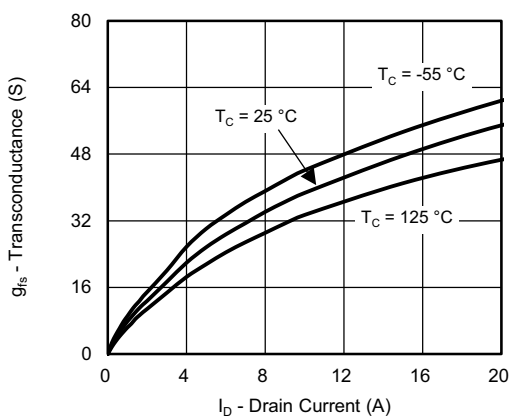
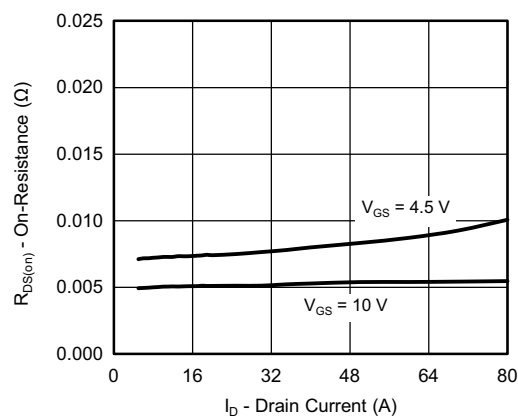
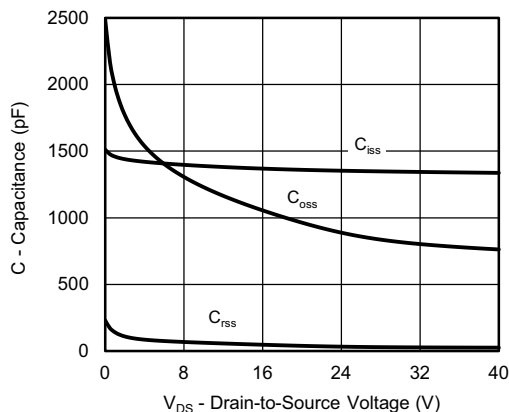
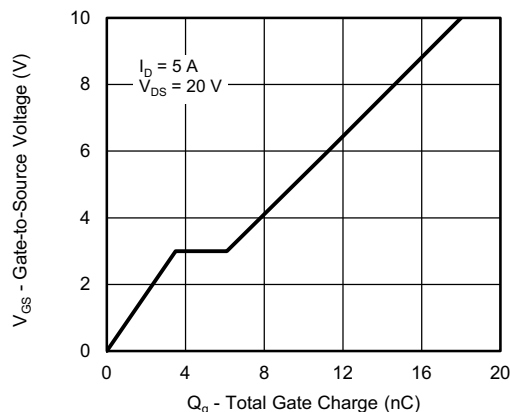
**SPECIFICATIONS** ($T_C = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Turn-on delay time ^c	t _{d(on)}	V _{DD} = 20 V, R _L = 4 Ω, I _D ≅ 5 A, V _{GEN} = 10 V, R _g = 1 Ω	N-Ch	-	11	20	ns
		V _{DD} = -20 V, R _L = 4 Ω, I _D ≅ -5 A, V _{GEN} = -10 V, R _g = 1 Ω	P-Ch	-	15	25	
Rise time ^c	t _r	V _{DD} = 20 V, R _L = 4 Ω, I _D ≅ 5 A, V _{GEN} = 10 V, R _g = 1 Ω	N-Ch	-	4	10	
		V _{DD} = -20 V, R _L = 4 Ω, I _D ≅ -5 A, V _{GEN} = -10 V, R _g = 1 Ω	P-Ch	-	6	10	
Turn-off delay time ^c	t _{d(off)}	V _{DD} = 20 V, R _L = 4 Ω, I _D ≅ 5 A, V _{GEN} = 10 V, R _g = 1 Ω	N-Ch	-	21	35	
		V _{DD} = -20 V, R _L = 4 Ω, I _D ≅ -5 A, V _{GEN} = -10 V, R _g = 1 Ω	P-Ch	-	45	70	
Fall time ^c	t _f	V _{DD} = 20 V, R _L = 4 Ω, I _D ≅ 5 A, V _{GEN} = 10 V, R _g = 1 Ω	N-Ch	-	5	10	
		V _{DD} = -20 V, R _L = 4 Ω, I _D ≅ -5 A, V _{GEN} = -10 V, R _g = 1 Ω	P-Ch	-	7	12	
Source-Drain Diode Ratings and Characteristics ^b							
Pulsed current ^a	I _{SM}		N-Ch	-	-	90	A
			P-Ch	-	-	-84	
Forward voltage	V _{SD}	I _S = 8 A, V _{GS} = 0 V	N-Ch	-	0.803	1.2	V
		I _S = -8 A, V _{GS} = 0 V	P-Ch	-	-0.790	-1.2	
Body diode reverse recovery time	t _{rr}	I _F = 5 A, di/dt = 100 A/μs	N-Ch	-	48	100	ns
		I _F = -5 A, di/dt = 100 A/μs	P-Ch	-	26	55	
Body diode reverse recovery charge	Q _{rr}	I _F = 5 A, di/dt = 100 A/μs	N-Ch	-	54	110	nC
		I _F = -5 A, di/dt = 100 A/μs	P-Ch	-	22	45	
Reverse recovery fall time	t _a	I _F = 5 A, di/dt = 100 A/μs	N-Ch	-	25	-	ns
		I _F = -5 A, di/dt = 100 A/μs	P-Ch	-	15	-	
Reverse recovery rise time	t _b	I _F = 5 A, di/dt = 100 A/μs	N-Ch	-	23	-	
		I _F = -5 A, di/dt = 100 A/μs	P-Ch	-	11	-	
Body diode peak reverse recovery current	I _{RM(REC)}	I _F = 5 A, di/dt = 100 A/μs	N-Ch	-	-2.1	-	A
		I _F = -5 A, di/dt = 100 A/μs	P-Ch	-	-1.7	-	

Notes

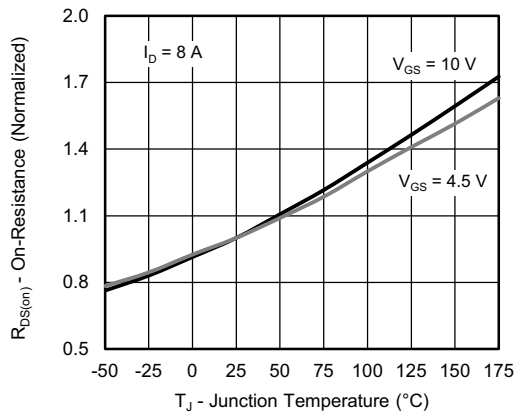
- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$
b. Guaranteed by design, not subject to production testing
c. Independent of operating temperature

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

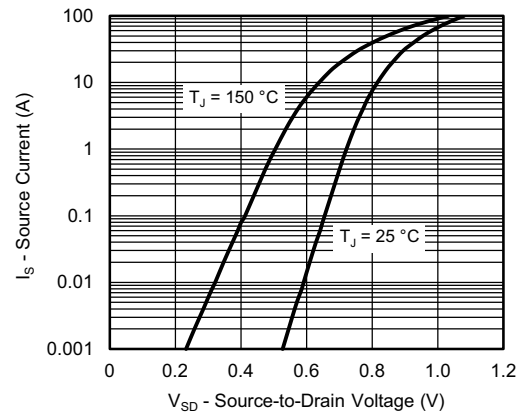
N-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)

Output Characteristics

Transfer Characteristics

Transconductance

On-Resistance vs. Drain Current

Capacitance

Gate Charge



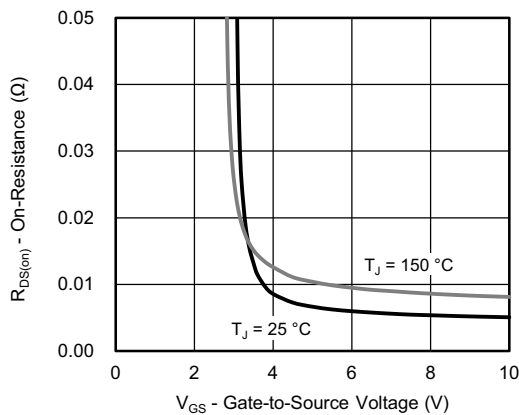
N-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$, unless otherwise noted)



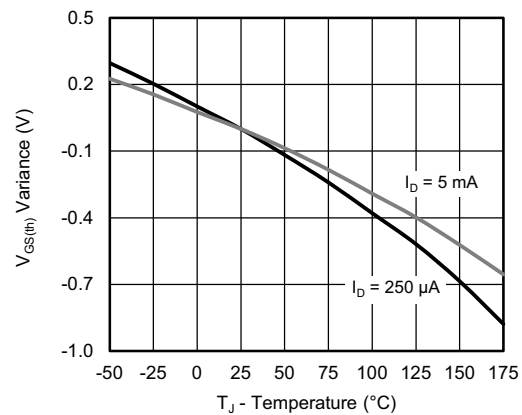
On-Resistance vs. Junction Temperature



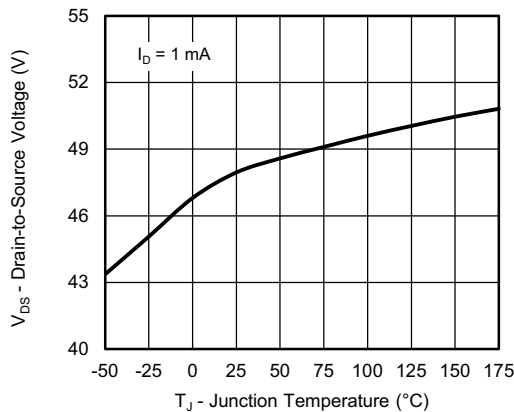
Source Drain Diode Forward Voltage



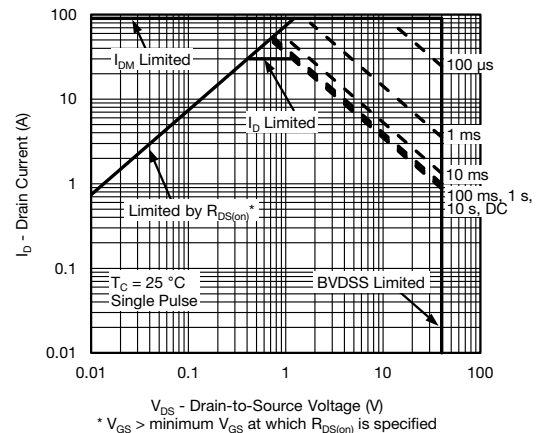
On-Resistance vs. Gate-to-Source Voltage



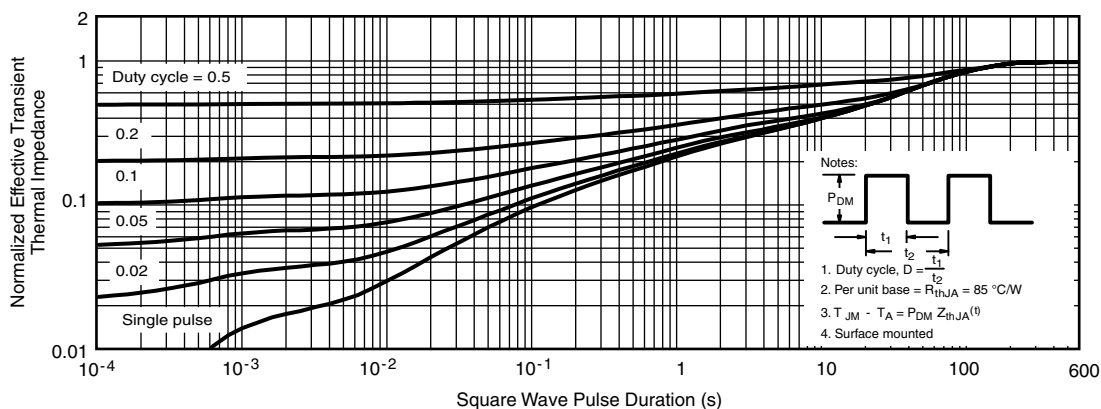
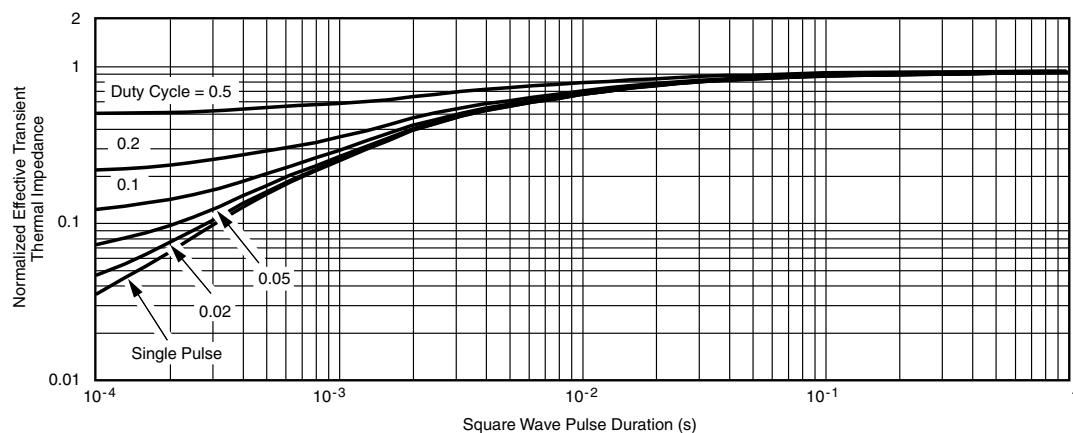
Threshold Voltage



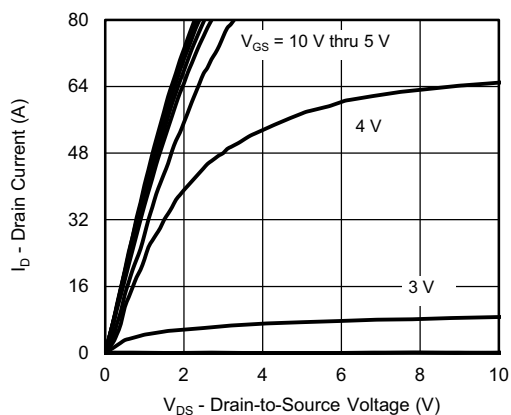
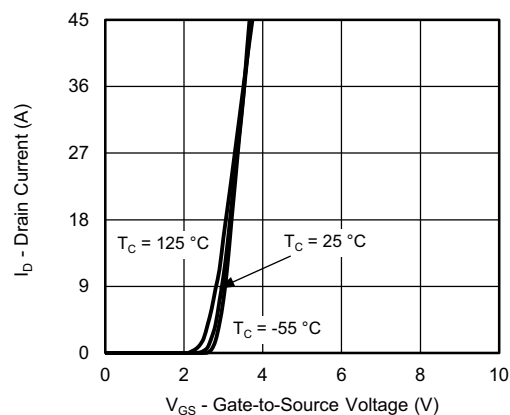
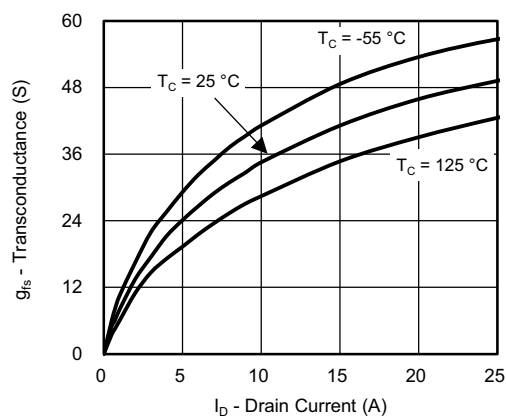
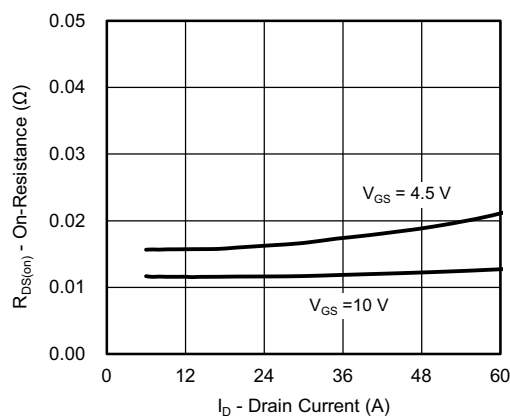
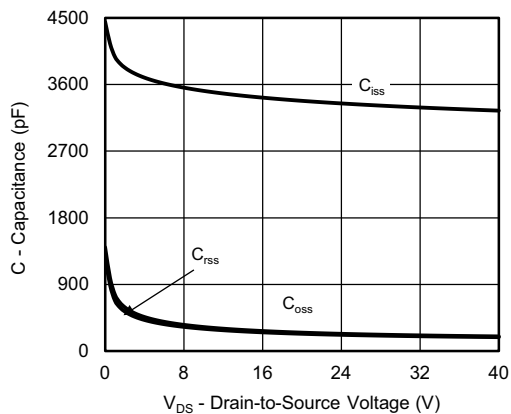
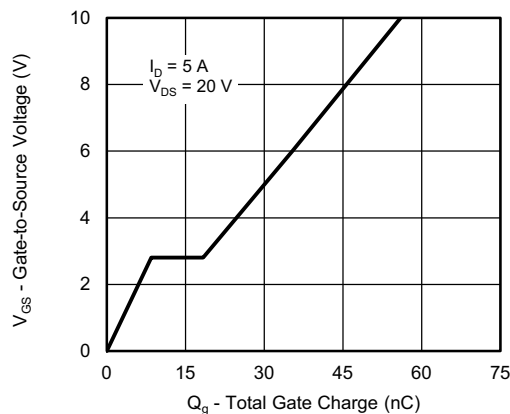
Drain Source Breakdown vs. Junction Temperature

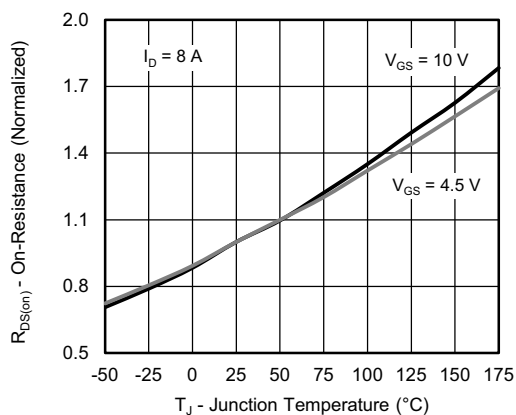
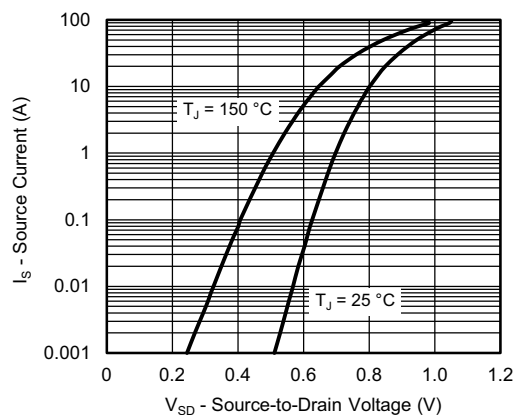
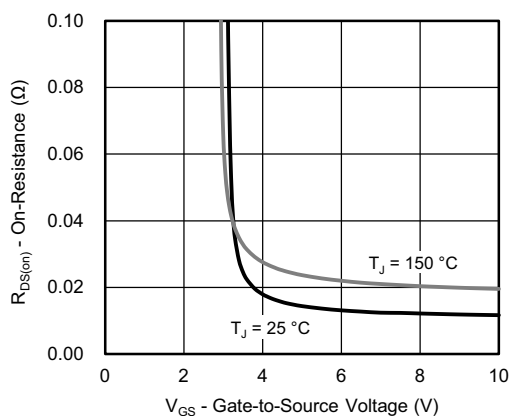
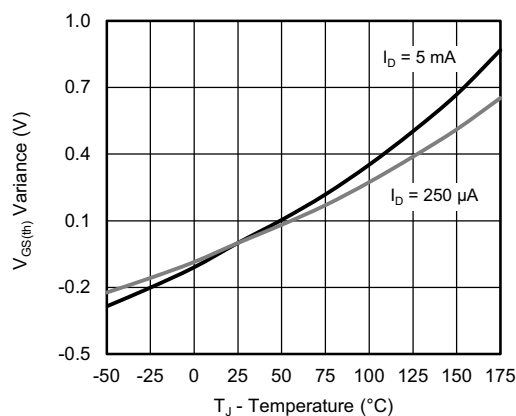
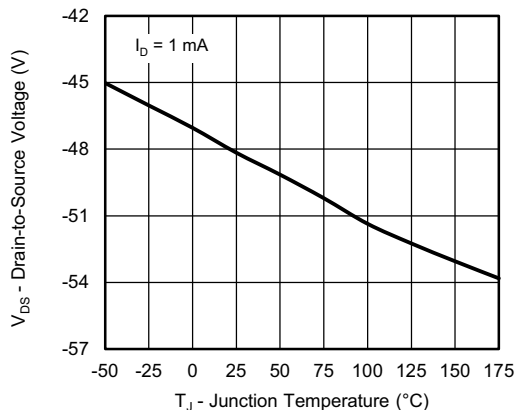
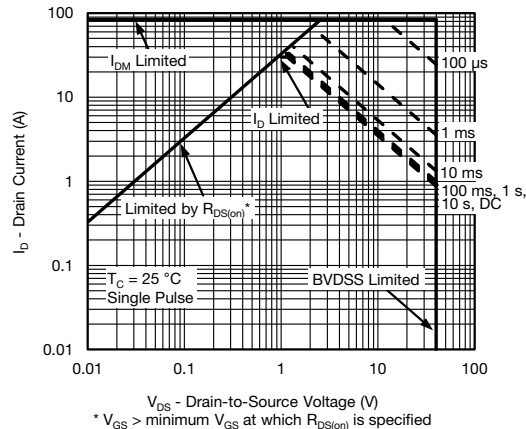


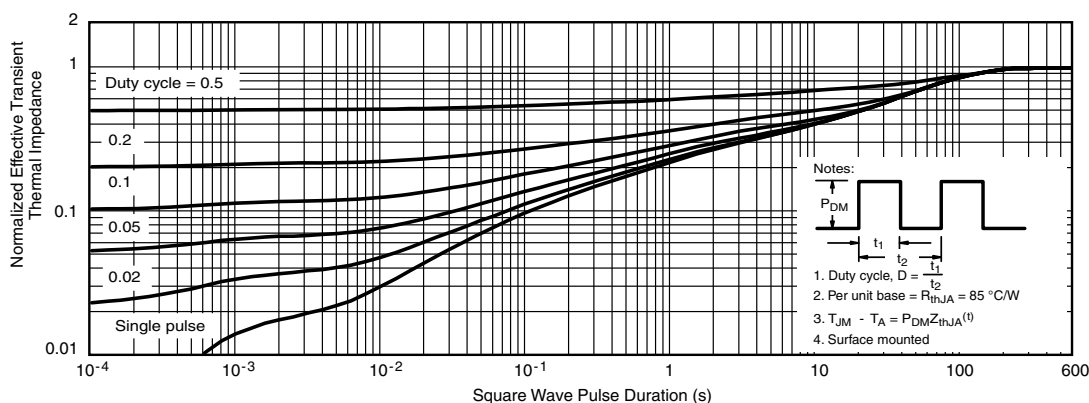
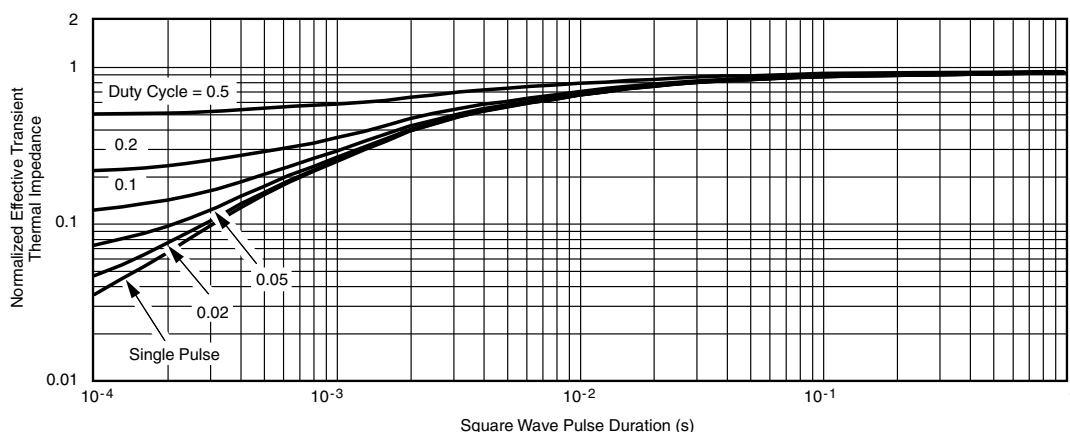
Safe Operating Area

N-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)

Normalized Thermal Transient Impedance, Junction-to-Ambient

Normalized Thermal Transient Impedance, Junction-to-Case
Note

- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction-to-Ambient ($25\text{ }^{\circ}\text{C}$)
 - Normalized Transient Thermal Impedance Junction-to-Case ($25\text{ }^{\circ}\text{C}$)
 are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions

P-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)

Output Characteristics

Transfer Characteristics

Transconductance

On-Resistance vs. Drain Current

Capacitance

Gate Charge

P-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)

Threshold Voltage

Source Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

Threshold Voltage

Drain Source Breakdown vs. Junction Temperature

Safe Operating Area

P-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)

Normalized Thermal Transient Impedance, Junction-to-Ambient

Normalized Thermal Transient Impedance, Junction-to-Case
Note

- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction-to-Ambient ($25\text{ }^{\circ}\text{C}$)
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<http://moschip.ru/get-element>

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Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

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Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

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